Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/084,566	MADRID ET AL.	
Examiner	Art Unit	
Nitin C. Patel	2116	

SEARCHED				
Class	Subclass	Date	Examiner	
713	500,501,5 02, 601	5/17/2005	NCP	
327	291, 156	5/17/2005	NCP	
377	78,80	5/17/2005	NCP	
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
Above	5/17/2005	NCP		
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	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East 2.0.1, USPAT, USPGPUB, USOCR, IBM_TDB, EPO, JPO, DERWENT	5/17/2005	NCP
consulted with primary examiner, Rehana Perveen	5/17/2005	NCP
ACM Digital libary	5/17/2005	NCP
IEEE Explorer	5/17/2005	NCP
West search history attached	5/17/2005	NCP